	 note	_

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/768,037	RIOUX ET AL.	
Examiner	Art Unit	
Lee S. Cohen	3739	

	SEAR	CHED	
Class	Subclass <sup>-</sup>	Date	Examiner
Updated	as above	8/31/2007	LSC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
`		
		1
		1
•		
		}